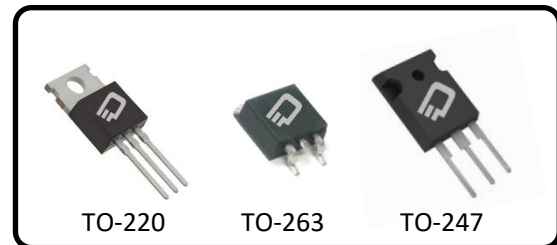


650V, 99mΩ, 31.8 A Super Junction Power MOSFET

Ordering Information

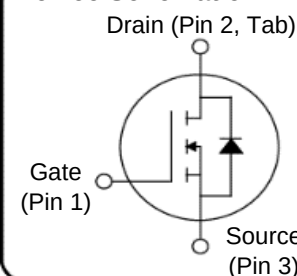
Part Number	Package Option
D3S099N65B-U	TO-220
D3S099N65D-U	TO-247
D3S099N65E-U	TO-263



Description

+FET™ is an advanced Super Junction Power MOSFET offering excellent efficiency through low $R_{DS(ON)}$ and low gate charge. +FET™ is a rugged device with precision charge balance implementation designed for demanding uses such as enterprise power computing power supplies, motor control, lighting and other challenging power conversion applications.

Device Schematic



Features

- LOW $R_{DS(ON)}$
- FAST SWITCHING
- HIGH E_{AS}
- REL TEST SPEC: JESD-22
- HTRB >3000 HRS

Benefits

- LOW CONDUCTION LOSSES
- HIGH EFFICIENCY
- EXCELLENT AVALANCHE PERFORMANCE

Table 1 Key Parameters

Parameter	Value	Unit
$V_{DSS} @ T_{jmax}$	710	V
$R_{DS(on)} max$	< 99	mΩ
$Q_g typ$	77	nC
$I_D @ 25 ^\circ C$	44.9	A

Applications

- POWER FACTOR CORRECTION
- SERVER POWER SUPPLIES
- TELECOM POWER SUPPLIES
- INVERTERS
- MOTOR CONTROL

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Maximum Ratings

Table 2 Maximum Ratings

@ T_j = 25°C, unless otherwise specified

Parameter	Symbol	Values			Unit	Condition
		Min	Typ	Max		
Continuous drain current	I _D			31.8	A	T _C = 25°C
				23.7	A	T _C = 100°C
Pulsed drain current	I _{D, pulse}			127	A	T _C = 25°C
Avalanche energy, single pulse	E _{AS}			650	mJ	I _D = 8.7A; V _{DD} = 50V, V _{GS} = 10V, L=17mH, R _G =25 Ohms
Avalanche energy, repetitive	E _{AR}			1.0	mJ	I _D = 8.7A; V _{DD} = 50V
Avalanche current, repetitive	I _{AR}			8.7	A	
MOSFET dv/dt ruggedness	dv/dt			50	V/ns	V _{DS} = 0...400V
Gate source voltage (static)	V _{GS}	-30		30	V	Static
Gate source voltage (dynamic)	V _{GS}	-30		30	V	AC (F>1Hz)
Power dissipation	P _{tot}			154	W	TO-220, TO-263, TO-247, T _C = 25°C
Storage temperature	T _{stg}	-55		150	°C	
Operating junction temperature	T _j	-55		150	°C	
Mounting torque				60	N-cm	
Continuous diode forward current	I _{SD}			31.8	A	T _C = 25°C
Diode pulse current	I _{S, pulse}			127	A	T _C = 25°C
Reverse diode dv/dt	dv/dt			15	V/ns	V _{DS} =0...400V, I _{SD} <=I _S , T _j = 25°C
Maximum diode commutation speed	di _f /dt			500	A/μs	V _{DS} =0...400V, I _{SD} <=I _S , T _j = 25°C

Thermal Characteristics

Table 3 Thermal Characteristics

Symbol	Parameter	Values				Unit
		TO-220	TO-263	TO-247		
R _{thjC}	Thermal resistance, junction-case	0.81	0.81	0.81		°C/W
R _{thjA}	Thermal resistance, junction-ambient	62	62	50		°C/W
R _{thjT}	Thermal resistance, junction-ambient for SMD version		30			°C/W
T _s	Soldering temperature, wavesoldering only allowed at leads	260	260	260		°C

Electrical Characteristics

@ $T_j = 25^\circ\text{C}$, unless otherwise specified

Table 4

Parameter	Symbol	Values			Unit	Condition
		Min	Typ	Max		
Drain-source breakdown voltage	V_{DS}	650			V	$I_D = 1\text{mA}$, $V_{GS} = 0\text{V}$
Gate threshold voltage	$V_{GS(th)}$	2.3	3	3.7	V	
Zero gate voltage drain current	I_{DSS}			1	μA	$V_{DS} = 650\text{V}$, $T_c = 25^\circ\text{C}$
				50		$V_{DS} = 650\text{V}$, $T_c = 125^\circ\text{C}$
Gate-source leakage current	I_{GSS}			100	nA	
Drain-source on-state resistance	$R_{DS(on)}$		0.062	0.099	Ω	$V_{GS} = 10\text{V}$, $I_D = 15.9\text{A}$, $T_c = 25^\circ\text{C}$
	$R_{DS(on)}$		0.160			$V_{GS} = 10\text{V}$, $I_D = 15.9\text{A}$, $T_c = 150^\circ\text{C}$
Gate resistance	R_G		1		Ω	

Table 5

Parameter	Symbol	Values			Unit	Condition
		Min	Typ	Max		
Input capacitance	C_{iss}		4240		pF	$V_{DS} = 100\text{V}$, $f = 1\text{MHz}$, $V_{GS} = 0\text{V}$
Output capacitance	C_{oss}		97.5		pF	
Reverse transfer capacitance	C_{rss}		16.5		pF	
Turn-on delay time	$t_{d(on)}$		17		ns	$V_{DD} = 400\text{V}$, $I_D = 15.9\text{A}$ $R_G = 1\Omega$, $V_{GS} = 10\text{V}$
Rise time	t_r		24		ns	
Turn-off delay time	$t_{d(off)}$		90		ns	
Fall time	t_f		23		ns	

Table 6 Gate Charge Characteristics

Parameter	Symbol	Values			Unit	Condition
		Min	Typ	Max		
Gate to source charge	Q_{gs}		16		nC	$V_{DD} = 480V$, $I_D = 15.5A$, $V_{GS} = 10V$
Gate to drain charge	Q_{gd}		27		nC	
Gate charge total	Q_g		77		nC	
Gate plateau voltage	$V_{plateau}$		5		V	

Table 7 Body Diode

Parameter	Symbol	Values			Unit	Condition
		Min	Typ	Max		
Diode source-drain current	I_{SD}			38.3	A	
Diode forward voltage	V_{fd}		0.95	1.5	V	$I_{SD} = 31.8A$, $V_{GS} = 0V$
Reverse recovery time	t_{rr}		468		ns	$I_{SD} = 31.8A$, $di/dt = 100A/\mu S$ $V_{DD} = 60V$, $T_c = 25^\circ C$
Reverse recovery charge	Q_{rr}		9.5		μC	
Peak reverse recovery current	I_{rrm}		50.0		A	

Electrical Characteristics Graphs

Table 8 Thermal Performance

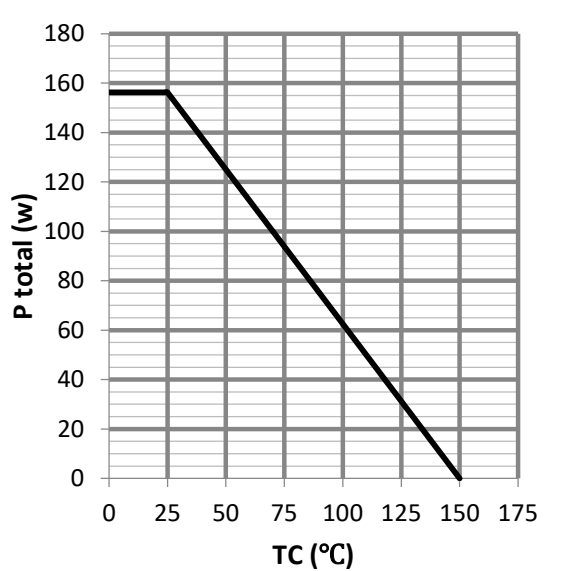
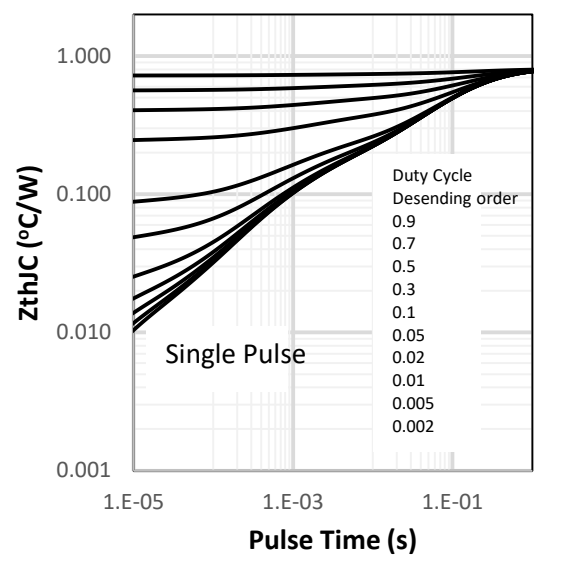
Power Dissipation	Maximum Transient Thermal Impedance
 The graph shows the maximum power dissipation (P_{total}) in Watts as a function of case temperature (T_C) in degrees Celsius. The y-axis ranges from 0 to 180 W, and the x-axis ranges from 0 to 175 °C. The power is constant at approximately 155 W for temperatures up to 25 °C, then decreases linearly to 0 W at 150 °C.	 The graph shows the maximum transient thermal impedance (Z_{thJC}) in °C/W as a function of pulse time (t_p) in seconds on a log-log scale. The y-axis ranges from 0.001 to 1.000 °C/W, and the x-axis ranges from 1.E-05 to 1.E-01 s. Multiple curves are shown for different duty cycles (0.9, 0.7, 0.5, 0.3, 0.1, 0.05, 0.02, 0.01, 0.005, 0.002), all converging to a value of 1.000 °C/W for pulse times greater than 0.1 s. A 'Single Pulse' curve is also shown, starting at approximately 0.01 °C/W for very short pulse times.
Max power limited by case temperature	Variable is pulse time (t _p)

Table 9 Output Characteristics

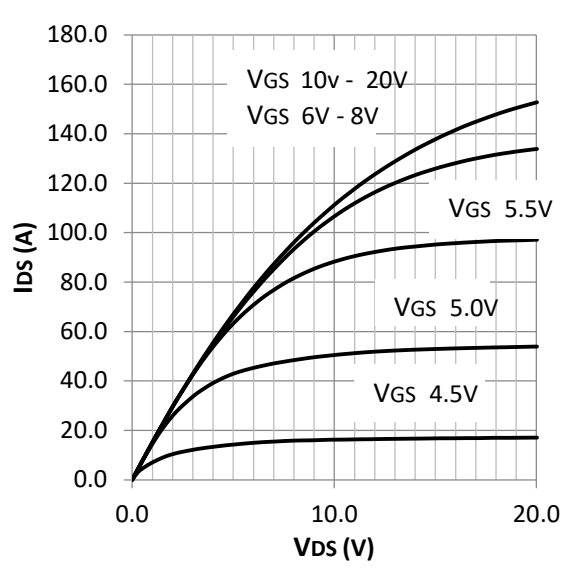
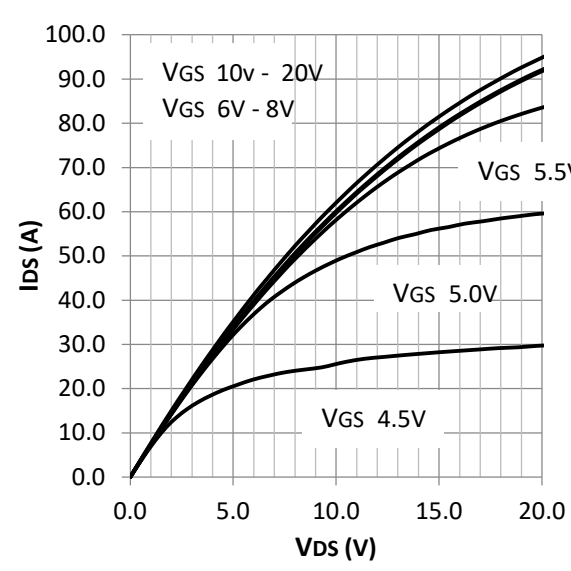
Typical Output Characteristics	Typical Output Characteristics
 The graph shows the drain current (I_{DS}) in Amperes versus the drain-source voltage (V_{DS}) in Volts at a case temperature (T_C) of 25 °C. The y-axis ranges from 0.0 to 180.0 A, and the x-axis ranges from 0.0 to 20.0 V. Multiple curves are shown for different gate-source voltages (V_{GS}): 10V - 20V, 6V - 8V, 5.5V, 5.0V, and 4.5V. The current increases with V_{DS} and is higher for higher V_{GS} values.	 The graph shows the drain current (I_{DS}) in Amperes versus the drain-source voltage (V_{DS}) in Volts at a case temperature (T_C) of 125 °C. The y-axis ranges from 0.0 to 100.0 A, and the x-axis ranges from 0.0 to 20.0 V. Multiple curves are shown for different gate-source voltages (V_{GS}): 10V - 20V, 6V - 8V, 5.5V, 5.0V, and 4.5V. The current is lower than at 25 °C for the same V_{GS} values.
T _C = 25°C; Variable is V _{GS}	T _C = 125°C; Variable is V _{GS}

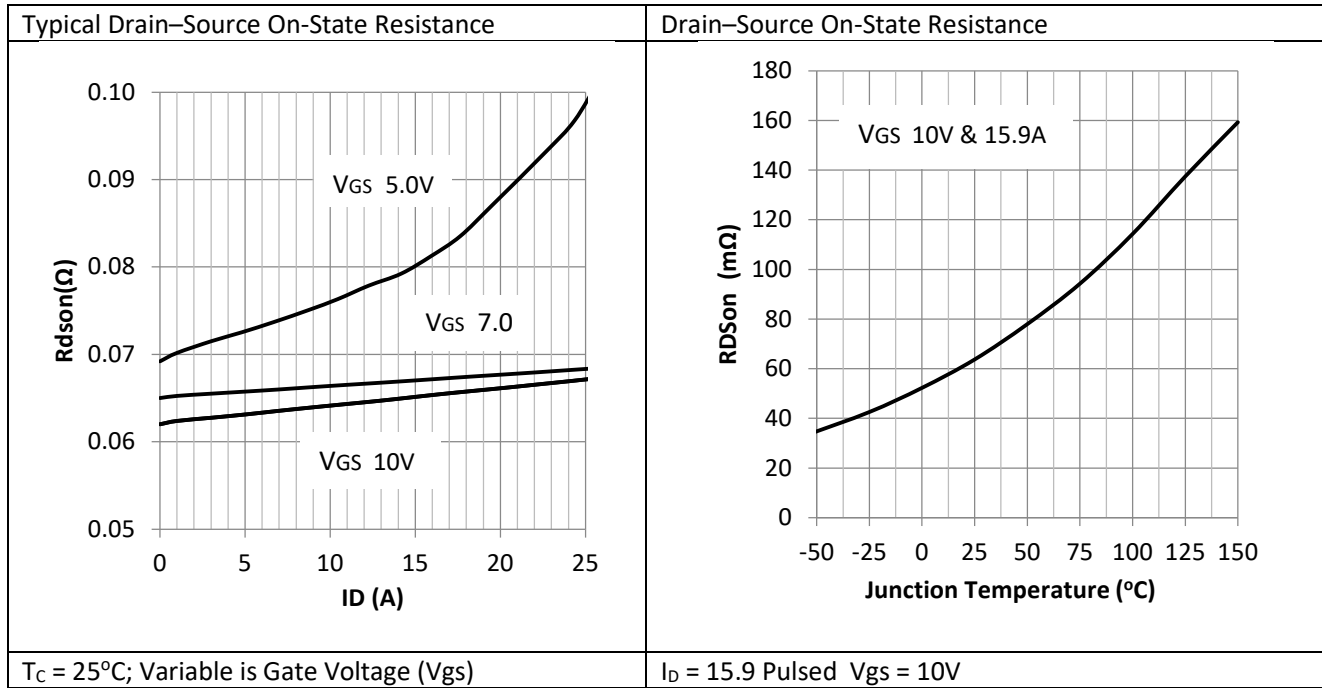
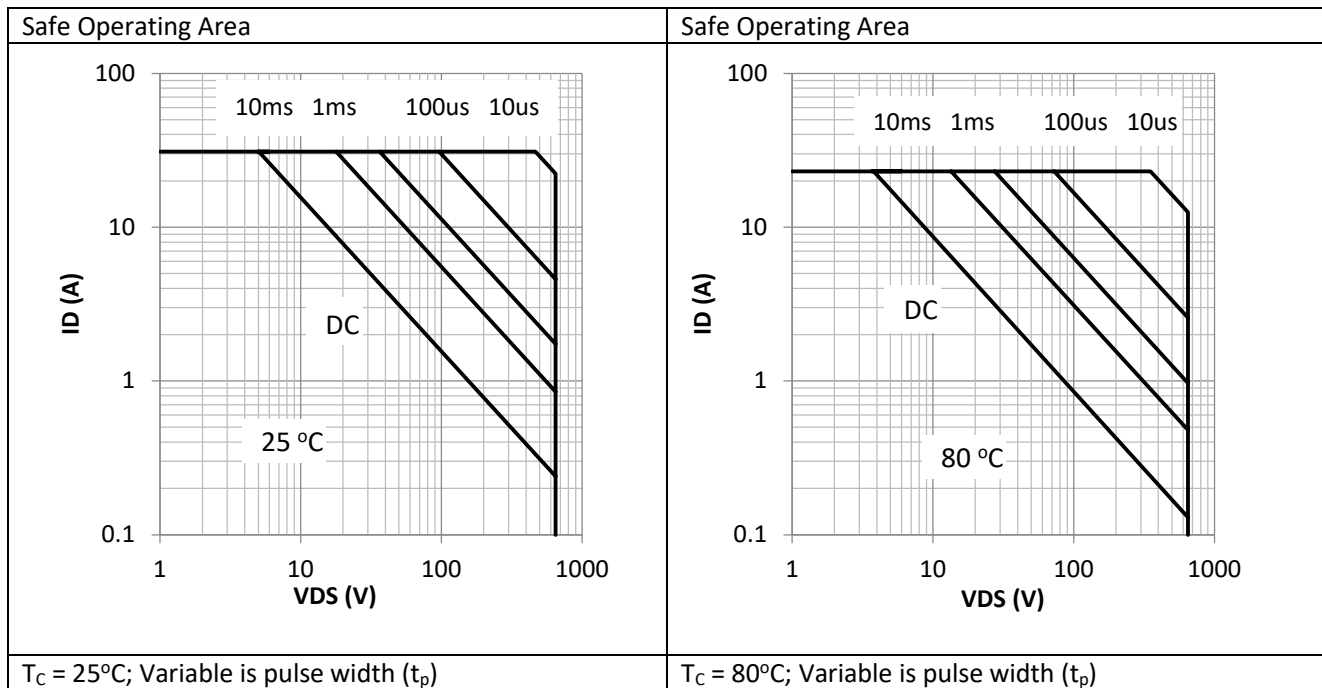
Table 10 Drain-Source Resistance

Table 11 Safe Operating Area


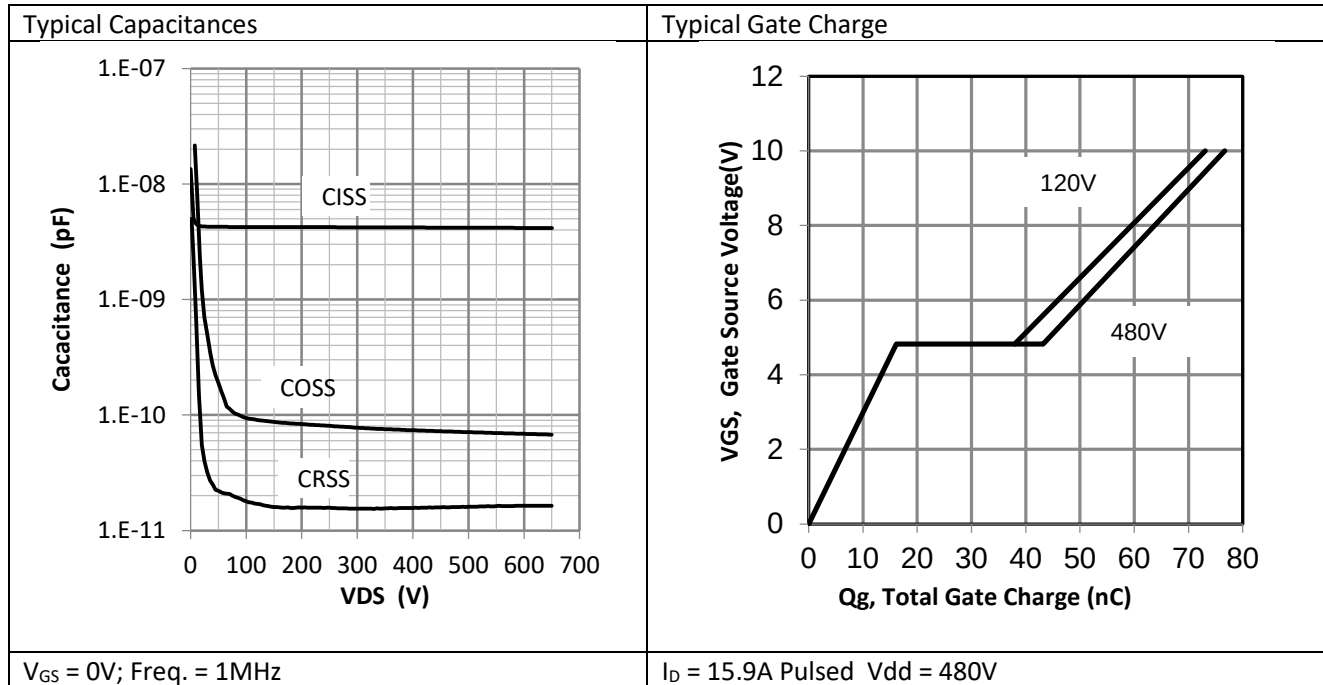
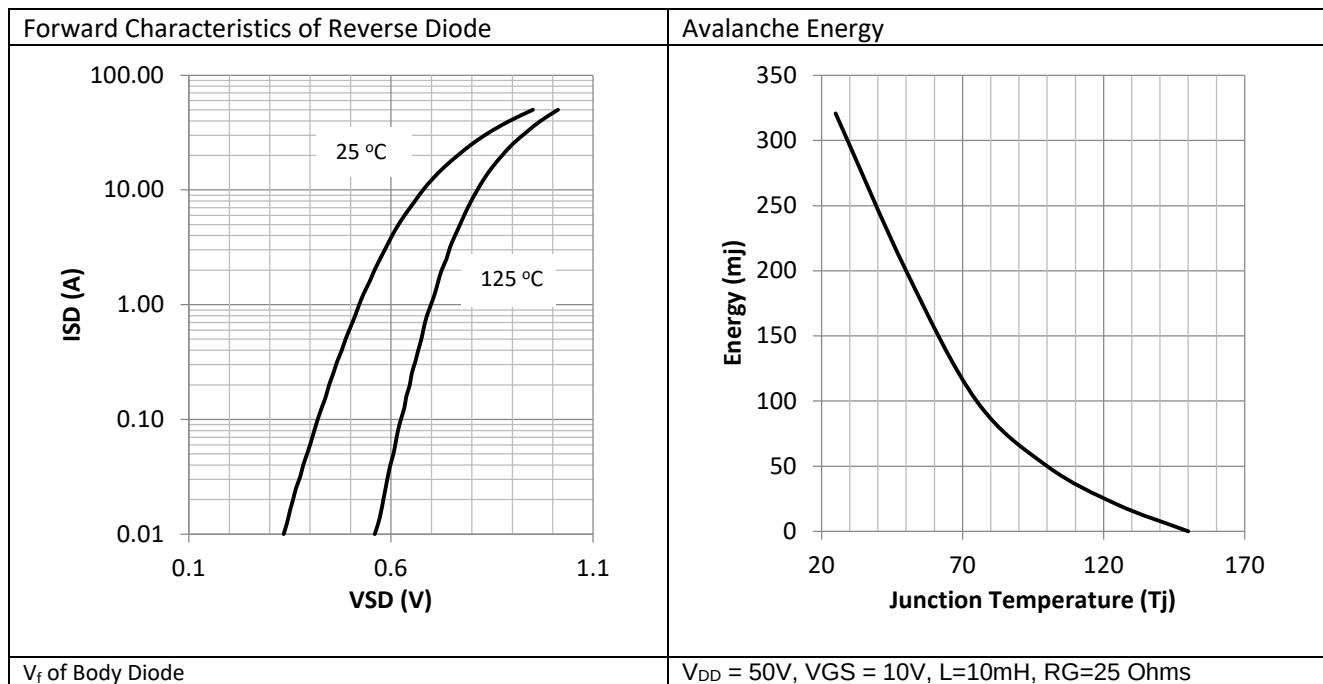
Table 12 Typical Capacitances and Gate Charge

Table 13 Diode Forward Characteristics and Avalanche Energy


Table 14 Drain – Source Breakdown Voltage and Typical Transfer Characteristics

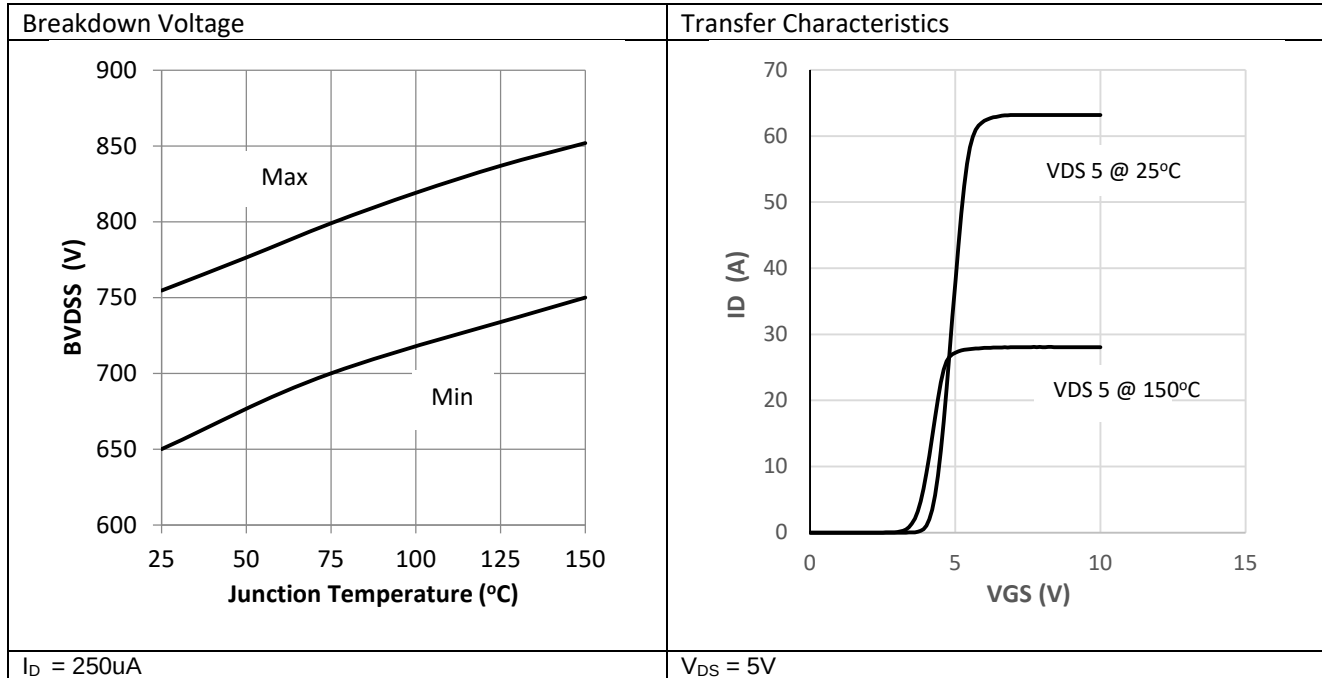


Table 15 Diode Recovery Characteristics

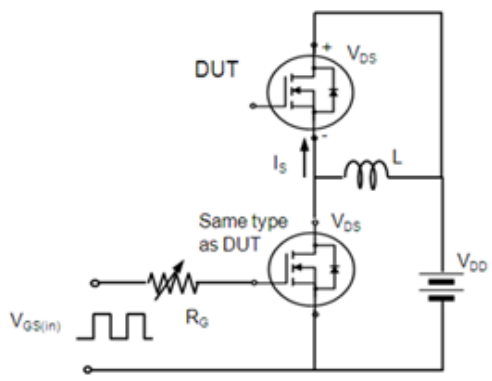
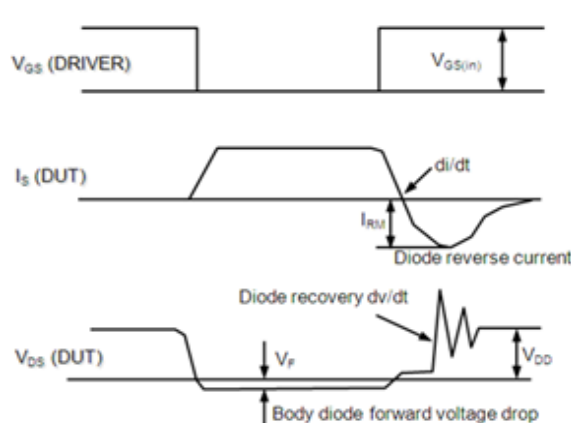
Test Circuit for Diode Recovery	Test Waveform for Diode Recovery
 *. dv/dt controlled by R_G *. I_S controlled by pulse period	

Table 16 Switching Time Characteristics

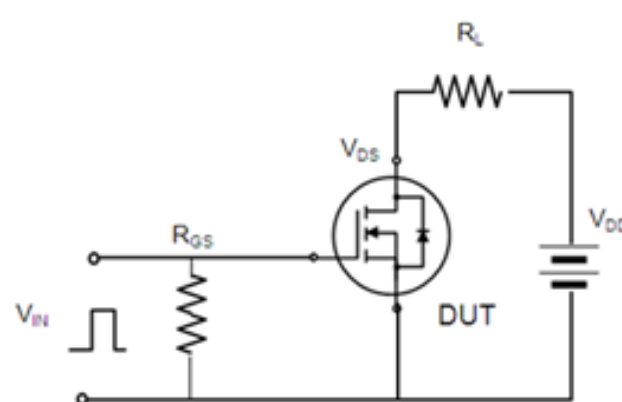
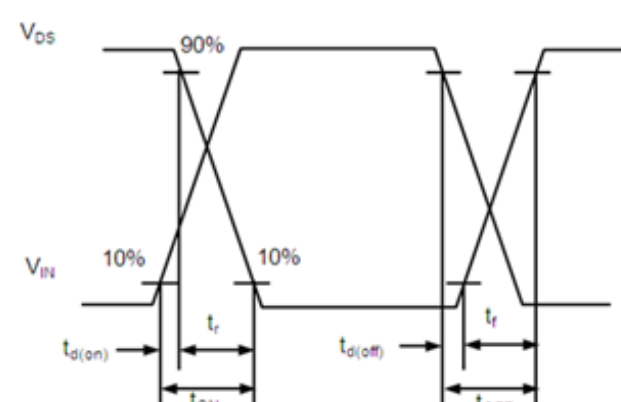
Test Circuit for Switching Time	Test Waveform for Switching Time
	

Table 17 Gate Charge Characteristics

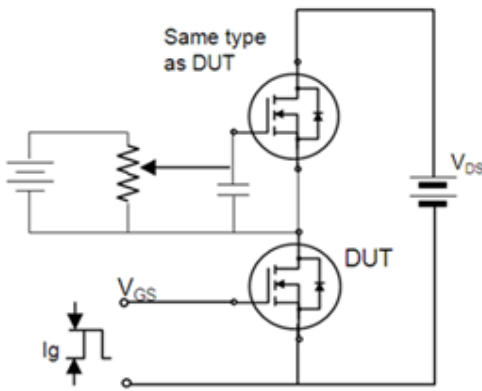
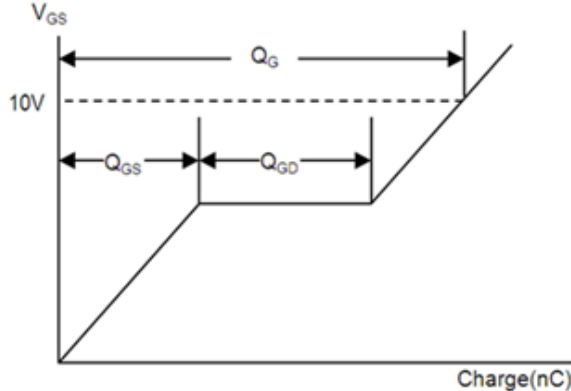
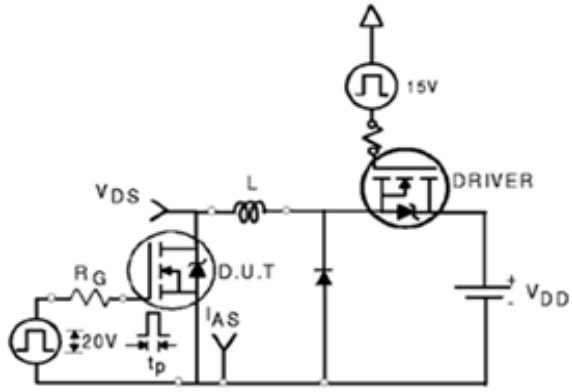
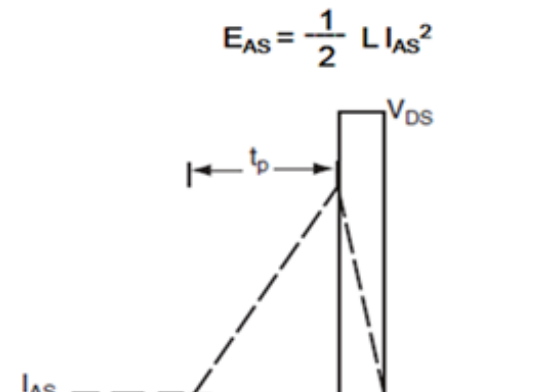
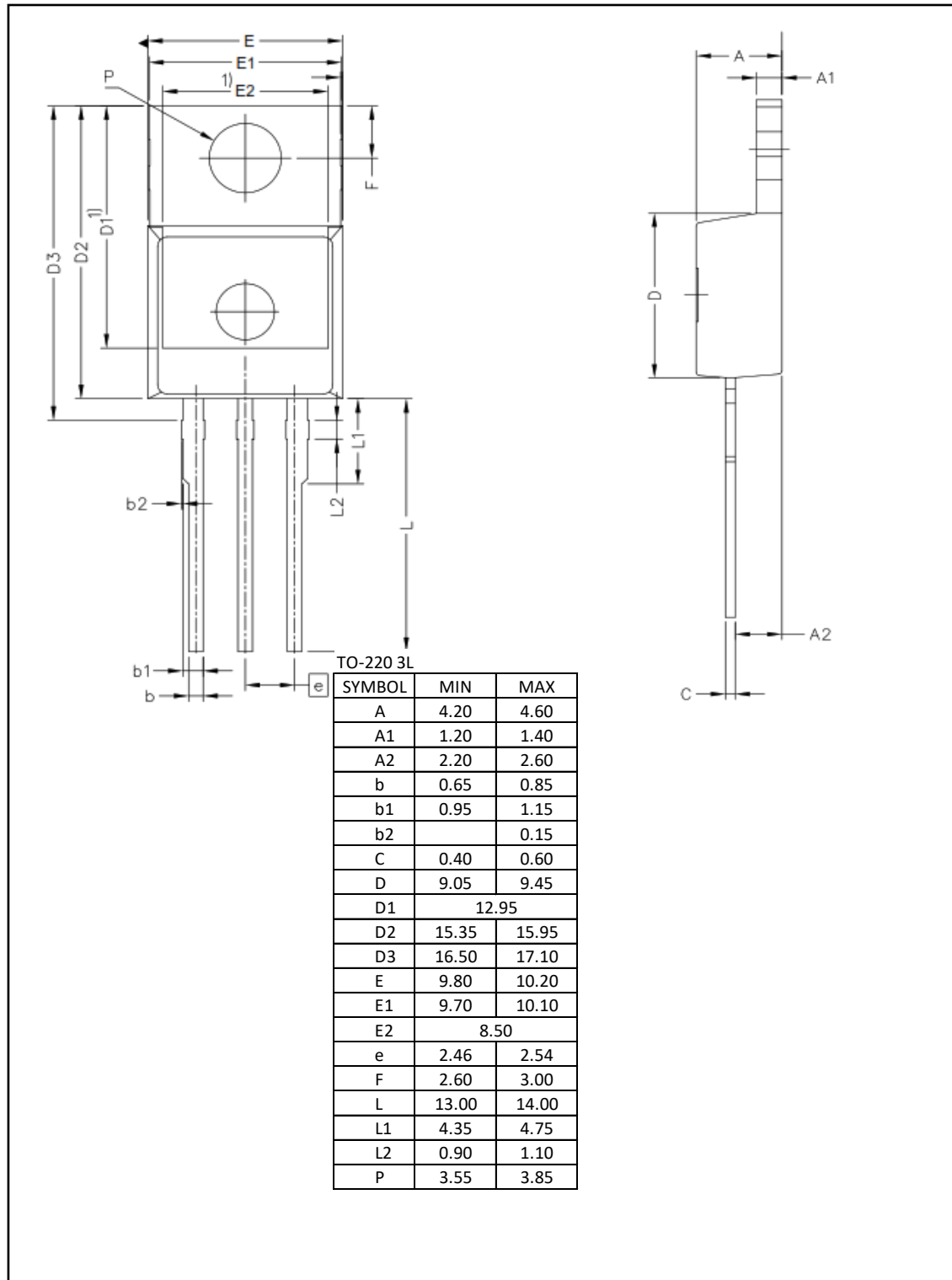
Test Circuit for Gate Charge	Test Waveform for Gate Charge
	

Table 18 Unclamped Inductive Switching Characteristic

Test Circuit for Unclamped Inductive Switching	Test Waveform for Unclamped Inductive Switching
	

4a) TO-220

D3 Semiconductor TO-220-3L

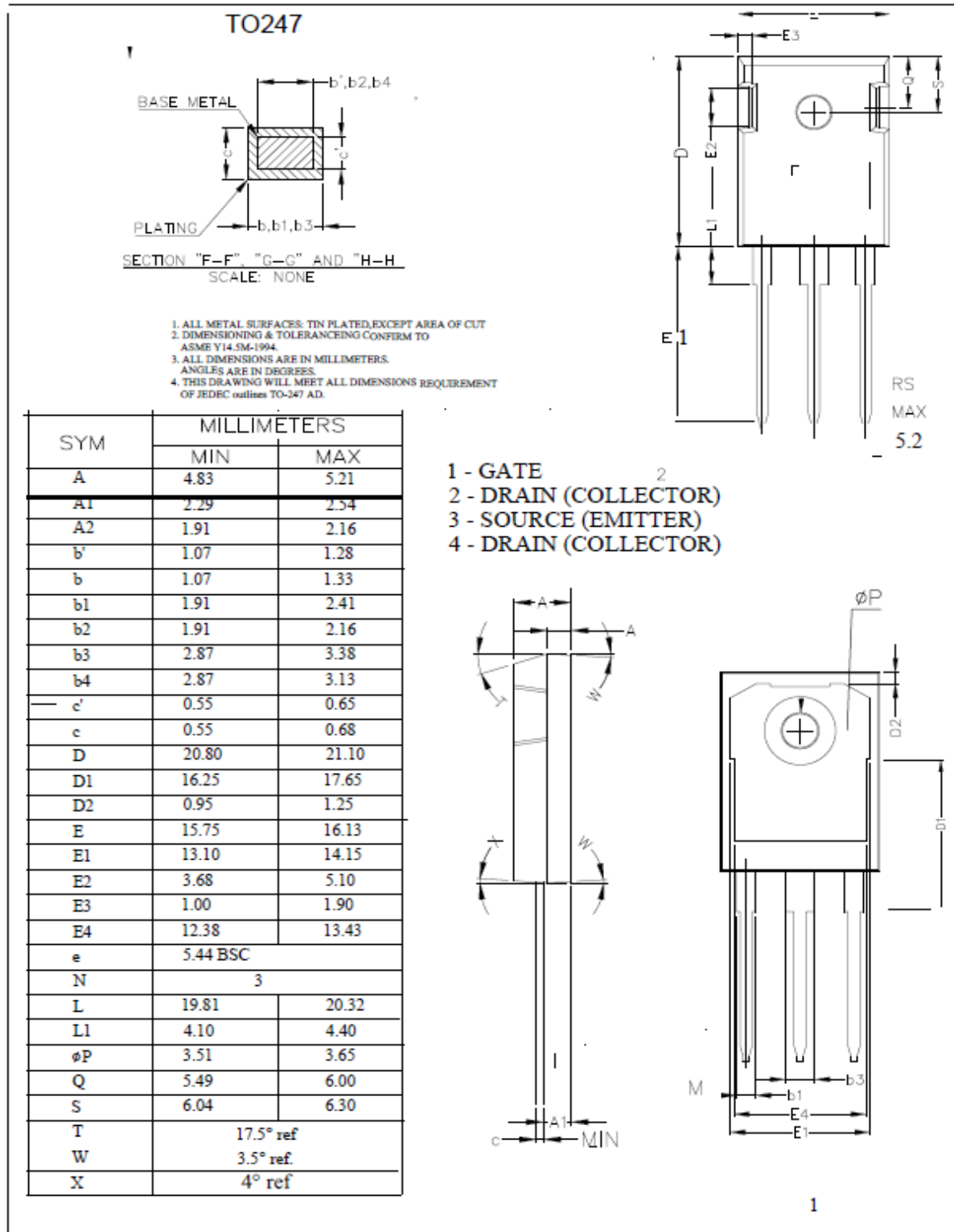


D3 Semiconductor TO-263 (D2PAK)



4c) TO-247

D3 Semiconductor TO-247 -3L



Revision History

Revision	Release Date	Comments
1.0	1-Nov-2016	Preliminary Datasheet
1.1	1-July-2017	Updated data tables and added packaging detail
2.3	20-Nov-2017	Added TO247 Package and Designers Datasheet
2.4	11-Dec-2017	Added Test Circuits

Resources

www.d3semi.com

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